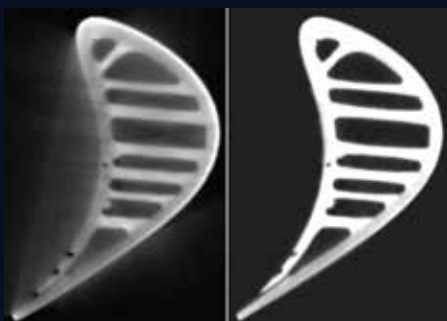


GE imagination at work

GE Inspection Technologies Receives Frost & Sullivan's 2016 Industrial Computed Tomography Company of the Year Award

GE Inspection Technologies has made significant contributions to the entire CT industry with its wide range of solutions. Namely with the recent launch of innovations like the fast unique helix CT speed|scan system, the high throughput blade inspection scanner phoenix v|tome|x c HS as well as world's first microCT system with scatter|correct technology, the high precision metrology phoenix v|tome|x m scanner, GE has consolidated its industrial CT market leadership.



Conventional CT scatter|correct

“ With its sound technological expertise and vast experience, GE has leveraged its non-destructive testing technology to design CT systems that combine the high precision of a fan beam CT scanner with the increased throughput (up to 100X faster) of automated cone beam CT inspection. ”

Mariano Kimbara | Industry Analyst | Frost & Sullivan